


<b>Search Notes</b> 	<b>Application/Control No.</b> 10681103	<b>Applicant(s)/Patent Under Reexamination</b> FEI ET AL.
	<b>Examiner</b> PAK, JOHN	<b>Art Unit</b> 1616

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN Online, Files HCAPLUS, WPIDS, MEDLINE. See printout	5/07	JP
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